

# MOSFET – Power, Single N-Channel 40 V, 0.67 mΩ, 370 A

# **NVMFS5C404NL**

### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS5C404NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage	)		V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	370	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		260	
Power Dissipation	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	200	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		100	
Continuous Drain	T <sub>A</sub> = 25°C		I <sub>D</sub>	52	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		37	
Power Dissipation	State $T_A = 25^{\circ}C$ $T_A = 100^{\circ}C$		$P_{D}$	3.9	W
R <sub>θJA</sub> (Notes 1 & 2)				1.9	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to + 175	°C
Source Current (Body Diode)			IS	191	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 38 A)			E <sub>AS</sub>	907	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

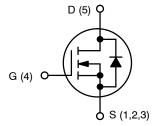
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.75	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.67 m $\Omega$ @ 10 V	070 4
40 V	1.0 mΩ @ 4.5 V	370 A



**N-CHANNEL MOSFET** 



XXXXXX = Specific Device Code

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

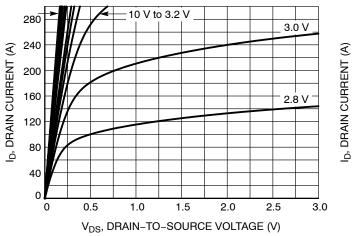
Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•		-	-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				21.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10	,
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>G</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-6.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.52	0.67	0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		0.75	1.0	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub>	<sub>)</sub> = 50 A		270		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>				12168		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			4538		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				79.8		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			81		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 2	20 V; I <sub>D</sub> = 50 A		181		1
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			8.5		nC
Gate-to-Source Charge	Q <sub>GS</sub>				27.8		1
Gate-to-Drain Charge	$Q_{GD}$				23.8		1
Plateau Voltage	$V_{GP}$				2.7		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				24		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	<sub>19</sub> = 20 V,		135		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 50 \text{ A}, R_G$	= 1.0 Ω		87		
Fall Time	t <sub>f</sub>				157		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS			•		•	•
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $T_J = 25^{\circ}\text{C}$	T <sub>J</sub> = 25°C		0.7	1.2	
		$I_{S} = 50 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.61		V
Reverse Recovery Time	t <sub>RR</sub>				97.4		
Charge Time	ta	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			46.5		ns
Discharge Time	t <sub>b</sub>				50.9		1
Reverse Recovery Charge	Q <sub>RR</sub>				190		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**

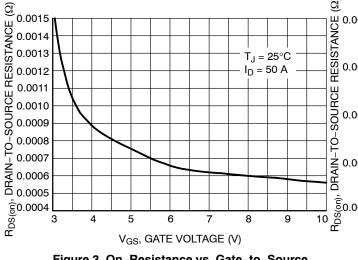
800



700 600 500 400 300  $T_J = 25^{\circ}C$ 200  $T_{J} = 125^{\circ}$ 100  $T_{.1} = -55^{\circ}C$ 0 0 0.5 2.0 3.0 3.5 1.0 1.5 2.5 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



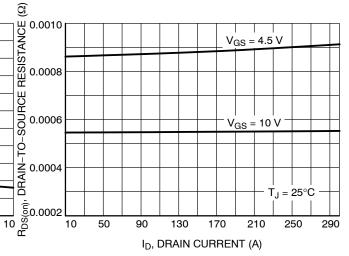
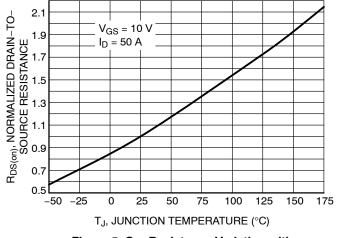


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



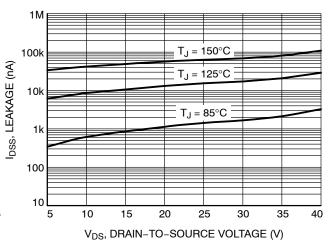
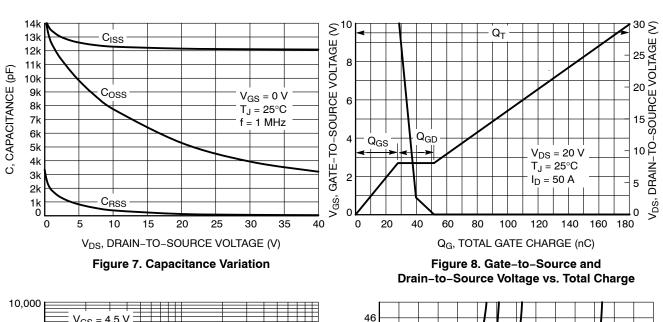


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

### **TYPICAL CHARACTERISTICS**



46  $V_{GS} = 4.5 V$  $V_{DD} = 20 \text{ V}$ 41 SOURCE CURRENT (A) t, TIME (ns)  $I_{D} = 50 \text{ A}$ 36 31 26 21 16 11 6 10 10 100 0.3  $R_G$ , GATE RESISTANCE ( $\Omega$ )

Figure 9. Resistive Switching Time Variation vs. Gate Resistance

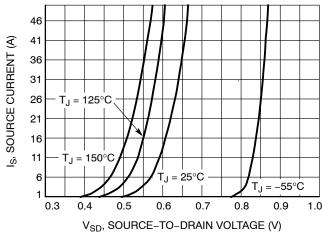


Figure 10. Diode Forward Voltage vs. Current

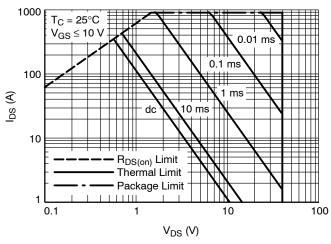


Figure 11. Safe Operating Area

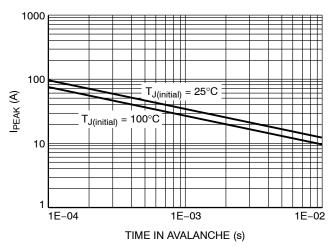


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

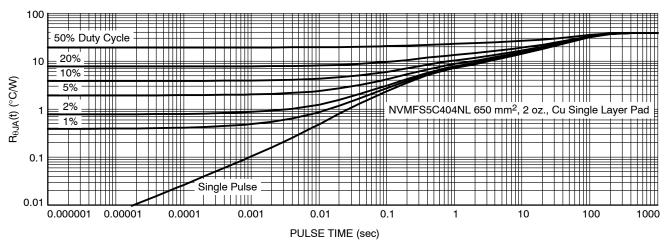


Figure 13. Thermal Characteristics

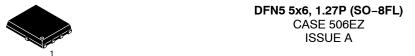
### **DEVICE ORDERING INFORMATION**

Device	Case	Marking	Package	Shipping <sup>†</sup>
NVMFS5C404NLT1G	506EZ	5C404L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C404NLWFT1G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C404NLT3G	506EZ	5C404L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5C404NLWFT3G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel
NVMFS5C404NLAFT1G	506EZ	5C404L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C404NLWFAFT1G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C404NLAFT3G	506EZ	5C404L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5C404NLWFAFT3G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

SCALE 2:1





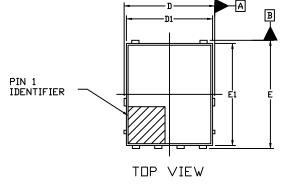
**DATE 25 AUG 2021** 

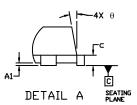
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
  2. CONTROLLING DIMENSION: MILLIMETERS
  3. DIMENSIONS DI AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, DR GATE BURRS.

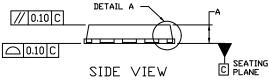
		MI	LLIMETE	25
	DIM	MIN.	N□M.	MAX.
-4X θ	Α	0.90	1.00	1.10
	A1	0.00		0.05
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	b	0.33	0.41	0.51
	С	0.23	0.28	0.33
t Y	D	5.00	5.15	5.30
DETAIL A SEATING PLANE	D1	4.70	4.90	5.10
FLANE	D2	3.80	4.00	4.20
	Е	6.00	6.15	6.30
	E1	5.70	5.90	6.10
	E2	3.45	3.80	3.85
	е		1.27 BSC	
i	G	0.51	0.575	0.71
	k	1.10	1.20	1.40
	L	0.51	0.575	0.71
	L1		0.125 RE	F
	М	3.00	3.40	3.80
	θ	0°		12*
2X (	0.4950 <del></del>	4.5	56 <del></del>	

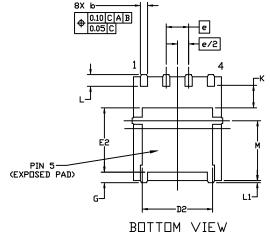
2X 0.25

2X 0.91











PACKAGE DUTLINE





For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

XXXXXX = Specific Device Code = Assembly Location

Α Υ = Year

W = Work Week

ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■" may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1

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**IDENTIFIER** 





CASE 507BA **ISSUE A** 



**MILLIMETERS** 

N□M.

0.575

0.575

0.150 REF

1.35

MAX. 1.10 0.05 0.51

0.33

5.30 5.10

4.20

6.30 6.10

3.85

0.71

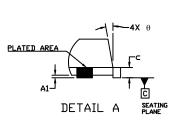
1.50

0.71



DIM

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
CONTROLLING DIMENSION: MILLIMETERS
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,
PROTRUSIONS, OR GATE BURRS.
THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN
FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



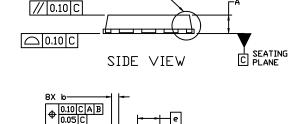
Α	0.90	1.00
A1	0.00	
b	0.33	0.41
С	0.23	0.28
D	5.00	5.15
D1	4.70	4.90
D2	3.80	4.00
Е	6.00	6.15
E1	5.70	5.90
E2	3.45	3.65
е		1.27 BSC

0.51

1.20

0.51

MIN



e/2

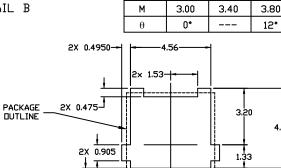
BOTTOM VIEW

-DETAIL B

DETAIL A

TOP VIEW





0.965

4X 1.00-

G

Κ

L1

### **GENERIC** MARKING DIAGRAM\*

PIN 5 (EXPOSED PAD)



= Assembly Location Α

Υ = Year W

ZZ

= Work Week = Lot Traceability

XXXXXX = Specific Device Code \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products

may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the  $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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4X 0.75

**DESCRIPTION:** DFNW5 5x6 (FULL-CUT SO8FL WF) **PAGE 1 OF 1** 

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